Analytic Confusion Matrix Bounds for Fault Detection and Isolation Using a Sum-of-Squared-Residuals Approach

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Abstract
Given a system which can fail in 1 of \( n \) different ways, a fault detection and isolation (FDI) algorithm uses sensor data in order to determine which fault is the most likely to have occurred. The effectiveness of an FDI algorithm can be quantified by a confusion matrix, which indicates the probability that each fault is isolated given that each fault has occurred. Confusion matrices are often generated with simulation data, particularly for complex systems. In this paper we perform FDI using sums of squares of sensor residuals (SSRs). We assume that the sensor residuals are Gaussian, which gives the SSRs a chi-squared distribution. We then generate analytic lower and upper bounds on the confusion matrix elements. This allows for the generation of optimal sensor sets without numerical simulations. The confusion matrix bounds are verified with simulated aircraft engine data.

1 Introduction
Many different methods of fault detection and isolation (FDI) have been proposed. Frequency domain methods include monitoring resonances [1] or modes [2]. Filter-based methods include observers [3], unknown input observers [4], Kalman filters [5], particle filters [6], sliding mode observers [7], \( H_\infty \) filters [8], and set membership filters [9]. There are also methods based on computer intelligence [10], include fuzzy logic [11], neural networks [12], genetic algorithms [13], and expert systems [14]. Other methods include those based on Markov models [15], system identification [16], wavelets [17], Bayesian inference [18], control input manipulation [19], and the parity space approach [20]. Many other FDI methods have also been proposed [21], some of which apply to special types of systems.

The parity space approach to FDI compares the sensor residual vector to nominal user-specified fault vectors, and the closest fault vector is isolated as the most likely fault. If the
sensor residual vectors are Gaussian, the parity space approach allows an analytic computation of the confusion matrix. The FDI approach that we propose is philosophically similar to the parity space approach, but instead of using fault vectors, we use sum-of-squared residuals (SSRs) in order to detect and isolate a fault. We do not compare our approach with other FDI methods, but our approach is chosen because of its amenability to a new statistical method for the calculation of confusion matrix bounds.

If sensor residuals are Gaussian, the SSRs have a chi-squared distribution [22]. This allows for the specification of SSR bounds for fault detection which have a known false negative rate and false positive rate. We can also compare the SSRs for each fault type to determine which fault is most likely to have occurred, and then find analytic bounds for fault isolation probabilities. Our FDI algorithm is new, but the primary contribution of this paper is to show how confusion matrix element bounds can be derived analytically. The FDI algorithm that we propose is fairly simple, but the confusion matrix analysis that we develop is novel and its ideas may be adaptable to other FDI algorithms.

Our approach is to first specify the magnitude of each fault that we want to detect, along with a target false positive rate (FPR). For each fault we then find the sensor set that gives the largest true positive rate (TPR) for the given FPR. Then we use statistical approaches to find confusion matrix bounds. The confusion matrix bounds are the outputs of this process. We cannot specify desired confusion matrix bounds ahead of time; the bounds are the dependent variables of the sensor selection process.

The goal of this paper is threefold. Our first goal is to present our SSR-based FDI algorithm, which we do in Section 2. Our second goal is to derive confusion matrix bounds, which we do in Section 3. Our third goal is to confirm the theory with simulation results, which we do in Section 4 using an aircraft turbofan engine model. Section 5 presents some discussion and conclusions.

2 A Simple SSR-Based FDI Algorithm

This section presents an overview of our simple SSR-based FDI algorithm, gives an overview of confusion matrix theory, and provides some fundamental lemmas that are used later. We consider FDI of a static, linear system. Sensor residuals are computed at each measurement time to perform fault detection, and the sum of the squares of the sensor residuals (SSR) are used to perform fault isolation. If the sensor residuals are Gaussian, then the SSRs have a chi-squared distribution, which allows the formulation of analytic bounds on the confusion matrix elements as discussed in Sections 3.1-3.3.

The residual of the $i$th sensor is denoted as $y_i$ and is a measurement of the difference between the sensor output and its nominal output in the no-fault case. In the no-fault case, $y_i$ is zero mean. In the fault case, the mean of $y_i$ is $\mu_i$. In either case, the standard deviation of $y_i$ is $\sigma_i$. The mean $\mu_i$ depends on which fault occurs, but for simplicity of notation we do
not indicate that dependence in our notation. An SSR is given as

\[ S = \sum_{i=1}^{k} \frac{(y_{i}/\sigma_{i})^2}{2} \]  

where \( k \) is the number of sensors used in this particular SSR. If each \( y_{i} \) is a zero-mean Gaussian random variable, then \( S \) is a random variable with a chi-squared distribution [22]. Its probability density function (pdf), and cumulative distribution function (cdf), are

\[ f(x, k) = \begin{cases} 2^{-k/2}(\Gamma(k/2))^{-1}x^{k/2-1}e^{-x/2} & x > 0 \\ 0 & x \leq 0 \end{cases} \]  

\[ F(x, k) = \begin{cases} \gamma(k/2, x/2)(\Gamma(k/2))^{-1} & x > 0 \\ 0 & x \leq 0 \end{cases} \]

where \( \Gamma(\cdot) \) is the gamma function and \( \gamma(\cdot) \) is the lower incomplete gamma function.

\[ \Gamma(z) = \int_{0}^{\infty} t^{z-1}e^{-t} dt \]  

\[ \gamma(z, a) = \int_{0}^{a} t^{z-1}e^{-t} dt \]

We will use a user-specified threshold \( T \) to detect a fault.

\[ S \geq T \rightarrow \text{fault detected} \]  

\[ S < T \rightarrow \text{no fault detected} \]

Note that fault isolation is a different issue than fault detection. Detection means that \( S_i \geq T_i \) for fault detection algorithm \( i \). However, it may be that \( S_i \geq T_i \) for more than one value of \( i \). In that case multiple faults have been detected and a fault isolation algorithm is required to isolate the most likely fault.

If a fault occurs, then the \( y_{i} \) terms in Equation 1 will not, in general, be zero mean. In this case \( S \) has a noncentral chi-squared distribution [22]. Its pdf and cdf are given as

\[ f(x, k, \lambda) = \frac{1}{2}e^{-(x+x+\lambda)/2}(x/\lambda)^{k/4-1/2}I_{k/2-1}\left(\sqrt{\lambda x}\right) \]  

\[ F(x, k, \lambda) = \sum_{j=0}^{\infty} \frac{e^{-\lambda/2}(\lambda/2)^j}{j!}F(x, k + j/2) \]

where \( \lambda \) is related to the means \( \mu_{i} \) of the sensor residuals \( y_{i} \), and \( I(\cdot) \) is a modified Bessel function of the first kind.

\[ \lambda = \sum_{i=1}^{k} \left(\frac{\mu_{i}}{\sigma_{i}}\right)^2 \]  

\[ I_{m}(y) = (y/2)^{m} \sum_{j=0}^{\infty} \frac{(y^{2}/4)^{j}}{j!\Gamma(m+j+1)} \]
We use the notation \( f_x(w) \) and \( F_x(w) \) to denote the pdf and cdf of the random variable \( x \) evaluated at \( w \). In terms of FDI, \( w \) will be equal to the SSR. If the random variable that is being used is clear from the surrounding text and mathematics, we shorten the notation to \( f(x) \) and \( F(x) \). We use \( f(x, k) \) and \( F(x, k) \) to denote the pdf and cdf of the chi-squared distribution, and \( f(x, k, \lambda) \) and \( F(x, k, \lambda) \) to denote the pdf and cdf of the noncentral chi-squared distribution.

A confusion matrix specifies the likelihood of isolating each fault, and can be used to quantify the performance of an FDI algorithm. A typical confusion matrix for FDI is shown in Table 1. The rows correspond to fault conditions, and the columns correspond to fault isolation results. The element in the \( i \)th row and \( j \)th column is the probability that fault \( j \) is isolated when fault \( i \) occurs. Ideally the confusion matrix would be an identity matrix, which would indicate perfect fault isolation.

In Table 1, \( \text{CCR}_i \) is the probability that fault \( i \) is correctly isolated given that it occurs. \( \text{CNR} \) is the probability that a no-fault condition is correctly indicated given that no fault occurs. \( M_{ij} \) is the probability that fault \( i \) is incorrectly isolated given that fault \( j \) occurs. \( M_{i0} \) is the probability that fault \( i \) is incorrectly isolated given that no fault occurs. \( M_{0i} \) is the probability that no fault is isolated given that fault \( i \) occurs.

Table 1: Typical confusion matrix format. The rows correspond to fault conditions, and the columns correspond to fault isolation results.

<table>
<thead>
<tr>
<th>Fault 1</th>
<th>Fault 2</th>
<th>\cdots</th>
<th>Fault n</th>
<th>No fault</th>
</tr>
</thead>
<tbody>
<tr>
<td>\text{CCR}_1</td>
<td>\text{M}_{12}</td>
<td>\cdots</td>
<td>\text{M}_{1n}</td>
<td>\text{M}_{10}</td>
</tr>
<tr>
<td>\text{M}_{12}</td>
<td>\text{CCR}_2</td>
<td>\cdots</td>
<td>\text{M}_{2n}</td>
<td>\text{M}_{20}</td>
</tr>
<tr>
<td>\cdots</td>
<td>\cdots</td>
<td>\cdots</td>
<td>\cdots</td>
<td>\cdots</td>
</tr>
<tr>
<td>\text{M}_{1n}</td>
<td>\text{M}_{2n}</td>
<td>\cdots</td>
<td>\text{CCR}_n</td>
<td>\text{M}_{0n}</td>
</tr>
<tr>
<td>\text{M}_{10}</td>
<td>\text{M}_{20}</td>
<td>\cdots</td>
<td>\text{M}_{0n}</td>
<td>\text{CNR}</td>
</tr>
</tbody>
</table>

In the remainder of this paper we use the following lemmas to derive results. These lemmas can be proven using standard definitions and results derived from probability theory [23, 24].

**Lemma 1** The probability that a realization of the random variable \( x \) is greater than a realization of the random variable \( y \) is given as

\[
P(x > y) = \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} f(x, y) \, dx \, dy
\]  

where \( f(x, y) \) is the joint pdf of \( x \) and \( y \). If \( x \) and \( y \) are independent, this can be written in terms of the marginal pdf’s as

\[
P(x > y) = \int_{-\infty}^{\infty} \left[ \int_{-\infty}^{\infty} f_x(w) \, dw \right] f_y(z) \, dz
\]  

\[
= \int_{-\infty}^{\infty} [1 - F_x(z)] f_y(z) \, dz
\]
Lemma 2 If \( y = T + x \), where \( x \) is a random variable and \( T \) is a constant, then

\[
\begin{align*}
    f_y(w) &= f_x(w - T) \\
    F_y(w) &= F_x(w - T)
\end{align*}
\] (15)

Lemma 3 If \( y = T - x \), where \( x \) is a random variable and \( T \) is a constant, then

\[
\begin{align*}
    f_y(w) &= f_x(T - w) \\
    F_y(w) &= 1 - F_x(T - w)
\end{align*}
\] (16)

Lemma 4 If \( z = \min(x, y) \), where \( x \) and \( y \) are independent random variables, then

\[
f_z(w) = f_x(w)(1 - F_y(w)) + f_y(w)(1 - F_x(w))
\] (17)

Lemma 5 If \( z = \min(x, T) \), where \( x \) is a random variable and \( T \) is a constant, then

\[
\begin{align*}
    F_z(w) &= \begin{cases} 
    F_x(w) & w < T \\
    1 & w \geq T 
    \end{cases} \\
    f_z(w) &= \begin{cases} 
    f_x(w) & w < T \\
    0 & w > T \\
    (1 - F_x(w))\delta(0) & w = T 
    \end{cases}
\end{align*}
\] (18)

where \( \delta(\cdot) \) is the continuous-time impulse function.

Lemma 6 If \( z = \max(x, y) \), where \( x \) and \( y \) are independent random variables, then

\[
f_z(w) = f_x(w)F_y(w) + f_y(w)F_x(w)
\] (19)

Lemma 7 If \( z = \max(x, T) \), where \( x \) is a random variable and \( T \) is a constant, then

\[
\begin{align*}
    F_z(w) &= \begin{cases} 
    F_x(w) & w \geq T \\
    0 & w < T 
    \end{cases} \\
    f_z(w) &= \begin{cases} 
    f_x(w) & w > T \\
    0 & w < T \\
    F_x(w)\delta(0) & w = T 
    \end{cases}
\end{align*}
\] (20)
3 Confusion Matrix Bounds

This section derives analytic confusion matrix bounds for our SSR-based FDI algorithm. Section 3.1 deals with the no-fault case and derives bounds for the correct no-fault rate (CNR), which is the probability that no fault is detected given that no fault occurs. It also derives bounds for the FPR, which is the probability that at least one fault is detected given that no fault occurred. Finally, it derives an upper bound for the no-fault misclassification rate, which is the probability that a given fault is isolated given that no fault occurred. Section 3.2 deals with the fault case and derives bounds for the correction classification rate (CCR), which is the probability that a given fault is correctly isolated given that it occurred. Section 3.3 also deals with the fault case and derives upper bounds for the fault misclassification rate, which is the probability that the incorrect fault is isolated given that some other fault occurred. Section 3.4 summarizes the bounds and their use in the confusion matrix, and Section 3.5 discusses the required computational effort.

3.1 No-Fault Case

The true negative rate (TNR) is the probability that \( S < T \) given that there are no faults. The false positive rate (FPR) is the probability that \( S \geq T \) given that there are no faults. If only one SSR is considered, these probabilities are given as

\[
\text{TNR}(T, k) = F(T, k) \\
\text{FPR}(T, k) = 1 - F(T, k)
\]  

(25)  

(26)

Figure 1 illustrates TNR and FPR for a chi-squared SSR containing \( k = 10 \) sensors and a detection threshold \( T = 25 \).

3.1.1 False positive rate: Two fault detection algorithms

Our FDI algorithm will have \( n \) fault detection algorithms running in parallel, where \( n \) is the number of possible faults. This will allow for the calculation of \( n \) SSRs, which will allow for their comparisons for fault isolation.

In this section we derive the FPR if two fault detection algorithms are running in parallel. Suppose that algorithm 1 attempts to detect fault 1 using \( k_{1a} \) sensors and threshold \( T_1 \), and algorithm 2 attempts to detect fault 2 using \( k_{2a} \) sensors and threshold \( T_2 \). We use the
Figure 1: Illustration of the chi-squared pdf of an SSR with $k = 10$ sensors. The true negative rate is the area to the left of the user-specified threshold $T = 25$, and the false positive rate is the area to the right of the threshold.

notation

\[
Y_1 = \{\text{sensors unique to algorithm 1}\} \quad (27)
\]
\[
Y_2 = \{\text{sensors unique to algorithm 2}\} \quad (28)
\]
\[
Y_c = \{\text{sensors common to algorithms 1 and 2}\} \quad (29)
\]
\[
\mathcal{Y}_1 = \{\text{all sensors used by algorithm 1}\} \quad (30)
\]
\[
= \{Y_1, Y_c\} \quad (31)
\]
\[
\mathcal{Y}_2 = \{\text{all sensors used by algorithm 2}\} \quad (32)
\]
\[
= \{Y_2, Y_c\} \quad (33)
\]

Note that some of the sensors used to detect fault 1 might also be used to detect fault 2, but some of the sensors used to detect fault 1 might not be used for fault 2 (and vice versa). Our algorithm therefore takes into account those sensor residuals that are unique to a given fault, and also those residuals that are common between faults. We use the notation $\mathcal{Y}_{1i}$ to
denote the \( i \)th normalized residual of the sensors used in algorithm 1, with similar meanings for \( Y_{2i}, Y_{1i}, Y_{ci} \), and \( Y_{ci} \). That is,

\[
S_1 = \sum Y_{1i}^2 = \sum Y_{1i}^2 + \sum Y_{ci}^2
\]

(34)

If there are no faults, then the probability that either fault 1 or fault 2 will be detected is

\[
FPR = P \left[ \left( \sum Y_{1i}^2 > T_1 \right) \text{ or } \left( \sum Y_{2i}^2 > T_2 \right) \right]
\]

(36)

\[
FPR = P \left[ \left( \sum Y_{1i}^2 + \sum Y_{ci}^2 > T_1 \right) \text{ or } \left( \sum Y_{2i}^2 + \sum Y_{ci}^2 > T_2 \right) \right]
\]

(37)

\[
FPR = P \left[ \left( \sum Y_{ci}^2 > T_1 - \sum Y_{1i}^2 \right) \text{ or } \left( \sum Y_{ci}^2 > T_2 - \sum Y_{2i}^2 \right) \right]
\]

(38)

\[
FPR = P \left[ \sum Y_{ci}^2 > \min \left( T_1 - \sum Y_{1i}^2, T_2 - \sum Y_{2i}^2 \right) \right]
\]

(39)

Note that \( \sum Y_{ci}^2, \sum Y_{1i}^2, \) and \( \sum Y_{2i}^2 \) are three independent random variables. If neither \( Y_1, Y_2, \) nor \( Y_c \) are empty, we can use Lemmas 1, 3, and 4 to obtain

\[
FPR = \int_{-\infty}^{\infty} \left[ 1 - F(y, k_c) \right] \left[ f(T_1 - y, k_1)F(T_2 - y, k_2) + f(T_2 - y, k_2)F(T_1 - y, k_1) \right] \, dy
\]

(40)

\[
k_1 = |Y_1|, \quad k_2 = |Y_2|, \quad k_c = |Y_c|
\]

(41)

Note that we are using the notation \( |Z| \) to denote the number of elements in the set \( Z \). If \( Y_1 \) is empty (sensor set 1 does not have any unique sensors), but \( Y_2 \) and \( Y_c \) are not empty, Equation 39 can be written as

\[
FPR = P \left[ \sum Y_{ci}^2 > \min \left( T_1, T_2 - \sum Y_{2i}^2 \right) \right]
\]

(42)

\[
FPR = P \left[ \sum Y_{ci}^2 > \min \left( T_1, a \right) \right]
\]

(43)

where \( a \) is defined by the above equation. Lemma 3 tells us that

\[
f_a(y) = f(T_2 - y, k_2)
\]

(44)

\[
F_a(y) = 1 - F(T_2 - y, k_2)
\]

(45)

Equations 42 and 43 can be written as

\[
FPR = P \left[ \sum Y_{ci}^2 > b \right]
\]

(46)

\[
b = \min (T_1, a)
\]

(47)

Lemma 5 tells us that

\[
f_b(y) = \begin{cases} 
  f_a(y) & y < T_1 \\
  0 & y > T_1 \\
  (1 - F_a(y))\delta(0) & y = T_1 
\end{cases}
\]

(48)
We can use Lemma 1 in conjunction with Equations 42–48 to write

\[ \text{FPR} = \int_{-\infty}^{\infty} [1 - F(y, k_c)] f_b(y) \, dy \quad (49) \]

\[ = \int_{-\infty}^{T_1} [1 - F(y, k_c)] f_a(y) \, dy + \int_{T_1}^{\infty} [1 - F(y, k_c)] [1 - F_a(y)] \delta(0) \, dy \quad (50) \]

\[ = \int_{-\infty}^{T_1} [1 - F(y, k_c)] f(T_2 - y, k_2) \, dy + [1 - F(T_1, k_c)] [1 - F_a(T_1)] \quad (51) \]

\[ = \int_{-\infty}^{\min(T_1, T_2)} [1 - F(y, k_c)] f(T_2 - y, k_2) \, dy + [1 - F(T_1, k_c)] F(T_2 - T_1, k_2) \quad (52) \]

\[ = \int_{-\infty}^{\min(T_1, T_2)} [1 - F(y, k_c)] f(T_2 - y, k_2) \, dy + [1 - F(T_1, k_c)] F(T_2 - T_1, k_2) \quad (53) \]

If \( Y_2 \) is empty (sensor set 2 does not have any unique sensors), but \( Y_1 \) and \( Y_c \) are not empty, we can use Lemmas 1, 3, and 5 to obtain

\[ \text{FPR} = P \left[ \sum Y_{i2}^2 > \min \left( T_1 - \sum Y_{1i}, T_2 \right) \right] \quad (54) \]

\[ = \int_{-\infty}^{\min(T_1, T_2)} [1 - F(y, k_c)] f(T_1 - y, k_1) \, dy + [1 - F(T_2, k_c)] F(T_1 - T_2, k_1) \quad (55) \]

If \( Y_c \) is empty (the two sensor sets do not have any common sensors), but \( Y_1 \) and \( Y_2 \) are not empty, we can use Lemmas 3 and 4 to obtain

\[ \text{FPR} = P \left[ 0 > \min \left( T_1 - \sum Y_{1i}^2, T_2 - \sum Y_{2i}^2 \right) \right] \quad (56) \]

\[ = \int_{-\infty}^{0} [f(T_1 - y, k_1)F(T_2 - y, k_2) + f(T_2 - y, k_2)F(T_1 - y, k_1)] \, dy \quad (57) \]

3.1.2 False positive rate: More than two fault detection algorithms

The previous section derived the FPR given that two fault detection algorithms are running in parallel. Now suppose that there are \( n > 2 \) fault detection algorithms. In this case we can write

\[ \text{FPR} = P [(S_1 > T_1) \text{ or } \cdots \text{ or } (S_n > T_n)] \quad (58) \]

\[ = 1 - P [(S_1 < T_1), \cdots, (S_n < T_n)] \quad (59) \]

\[ = 1 - \text{CNR} \quad (60) \]

where CNR is the correct no-fault rate. CNR is the probability that all of the SSRs are below their detection thresholds given that no fault occurred, and can be written as

\[ \text{CNR} = P [(S_1 < T_1), \cdots, (S_n < T_n)] \quad (61) \]
This can be bounded as
\[ \prod_{i=1}^{n} \text{TNR}(T_i, k_i) \leq \text{CNR} \leq \min_i \text{TNR}(T_i, k_i) \] (62)

The lower bound will be exact if none of the fault detection algorithms have any sensors in common, which means that \( \text{TNR}(T_i, k_i) \) and \( \text{TNR}(T_j, k_j) \) are independent for all \( i \neq j \). The upper bound will be exact if there is some \( m \) such that \( Y_m \) is a superset of \( Y_i \) for all \( i \neq m \), and \( \text{TNR}(T_m, k_m) \leq \text{TNR}(T_i, k_i) \) for all \( i \neq m \).

We can use Equations 60 and 62 to obtain bounds for the FPR when \( n > 2 \) fault detection algorithms are running in parallel.

\[ 1 - \min_i \text{TNR}(T_i, k_i) \leq \text{FPR} \leq 1 - \prod_{i=1}^{n} \text{TNR}(T_i, k_i) \] (63)

### 3.1.3 Fault misclassification rates in the no-fault case

Given that no fault occurred, the probability that fault \( i \) is incorrectly isolated is called the misclassification rate, \( M_{i0} \). In this section we derive upper bounds for this probability.

Suppose that we have \( n \) fault detectors running in parallel. Given that a fault is detected, that is, that the SSR of at least one fault detector exceeds its threshold, we propose isolating the fault using the following logic.

\[ \hat{p} = \arg \max_p \left( \sum_i Y_i^2 - T_p \right) \] (64)

### Two fault detection algorithms

Suppose that we have only two fault detection algorithms, algorithms 1 and 2. Given that no fault occurred, the probability that fault 1 is isolated is called the marginal misclassification of fault 1 relative to fault 2, and is given as

\[ M_{10,2} = P[(S_1 > T_1, (S_1 - T_1 > S_2 - T_2)] \] (65)

\[ = P \left[ \sum_i Y_i^2 > \max \left( T_1 - \sum_i Y_{ci}, \sum_i Y_{ci}^2 + T_1 - T_2 \right) \right] \] (66)

If neither \( Y_1, Y_2 \), nor \( Y_c \) are empty, we can use Lemmas 1, 2, 3, and 6 to obtain

\[ M_{10,2} = \int_{-\infty}^{\infty} [1 - F(y, k_1)] [F(y + T_2 - T_1, k_2) f(T_1 - y, k_c) + f(y + T_2 - T_1, k_2) (1 - F(T_1 - y, k_c))] \, dy \] (67)

In order to find finite integration limits that do not result in an excessive loss of accuracy in the computation of \( M_{10,2} \), we use our knowledge that \( f(w, k) = 0 \) for \( w < 0 \), and we find
values of $z_2$ and $z_c$ such that $f(z_2, k_2) < \epsilon$ and $f(z_c, k_c) < \epsilon$ for some small user-specified threshold $\epsilon$. This gives
\[
M_{10,2} = \int_L^{U} [1 - F(y, k_1)] [F(y + T_2 - T_1, k_2) f(T_1 - y, k_c) + f(y + T_2 - T_1, k_2) (1 - F(T_1 - y, k_c))] \, dy
\]
\[
L = \min(T_1 - T_2, T_1 - z_c)
\]
\[
U = \max(T_1, z_2 + T_1 - T_2)
\] (68)

If $Y_1$ is empty (sensor set 1 does not have any unique sensors), but $Y_2$ and $Y_c$ are not empty, the marginal misclassification rate can be derived as
\[
M_{10,2} = P \left[ 0 > \max \left( \sum_i Y_{2i}^2 + T_1 - T_2, T_1 - \sum_i Y_{ci}^2 \right) \right]
\]
\[
= P \left( \sum_i Y_{2i}^2 < T_2 - T_1 \right) P \left( \sum_i Y_{ci}^2 > T_1 \right)
\]
\[
= F(T_2 - T_1, k_2) [1 - F(T_1, k_c)]
\] (71)

If $Y_2$ is empty (sensor set 2 does not have any unique sensors), but $Y_1$ and $Y_c$ are not empty, the marginal misclassification rate can be derived as
\[
M_{10,2} = P \left[ \sum_i Y_{1i}^2 > \max \left( T_1 - \sum_i Y_{ci}^2, T_1 - T_2 \right) \right]
\]
\[
= \int_{-\infty}^{\infty} \left[ 1 - F(y, k_1) \right] f(y + T_2 - T_1, k_2) \, dy
\]
\[
= [1 - F(T_1 - T_2, k_1)] [1 - F(T_2, k_c)] + \int_{T_1 - T_2}^{T_1} [1 - F(y, k_1)] f(T_1 - y, k_c) \, dy
\] (75)

If $Y_c$ is empty (the two sensor sets do not have any common sensors), but $Y_1$ and $Y_2$ are not empty, the marginal misclassification rate can be derived as
\[
M_{10,2} = P \left[ \sum_i Y_{1i}^2 > \max \left( \sum_i Y_{2i}^2 + T_1 - T_2, T_1 \right) \right]
\]
\[
= \int_{-\infty}^{\infty} \left[ 1 - F(y, k_1) \right] f(y + T_2 - T_1, k_2) \, dy
\]
\[
= [1 - F(T_1, k_1)] f(T_2, k_c) + \int_{T_1}^{\infty} [1 - F(y, k_1)] f(y + T_2 - T_1, k_2) \, dy
\] (77)

We can use Lemmas 1, 2, and 7 to write this equation as
\[
M_{10,2} = P \left[ \sum_i Y_{1i}^2 > \max \left( \sum_i Y_{2i}^2 + T_1 - T_2, T_1 \right) \right]
\]
\[
= \int_{-\infty}^{\infty} \left[ 1 - F(y, k_1) \right] f(y + T_2 - T_1, k_2) \, dy + \int_{T_1}^{\infty} [1 - F(y, k_1)] f(y + T_2 - T_1, k_2) \, dy
\] (79)
In order to find finite integration limits that do not result in an excessive loss of accuracy in the computation of $M_{10,2}$, we find $z$ such that $f(z, k_2) < \epsilon$ for some small user-specified threshold $\epsilon$. This gives

$$M_{10,2} = [1 - F(T_1, k_1)] F(T_2, k_2) + \int_{T_1}^{z+T_1 - T_2} [1 - F(y, k_1)] f(y + T_2 - T_1, k_2) dy$$  \hspace{1cm} (80)$$

Given that no fault occurred and there are only two fault detection algorithms, the probability that fault 1 is isolated is given by Equation 68, 73, 76, or 80.

More than two fault detection algorithms

If we have $n > 2$ fault detection algorithms, the probability that fault 1 is isolated given that no fault occurred is the probability that SSR$_1$ is greater than its threshold, and greater than all of the other SSRs relative to their thresholds.

$$M_{10} = P[(S_1 > T_1), (S_1 - T_1 > S_2 - T_2), \cdots , (S_1 - T_1 > S_n - T_n)] \hspace{1cm} (81)$$

$$\leq \min_i M_{10,i} \hspace{1cm} (82)$$

So in order to obtain an upper bound for the misclassification rate of fault 1 given that no fault occurred, we use Equations 68, 73, 76, or 80 as appropriate to find the marginal misclassification rates. Then we use Equation 82 to find an upper bound for $M_{10}$.

3.2 Correct Fault Classification Rates

The true positive rate (TPR) is defined as the probability that a fault is correctly detected ($S > T$) given that it occurs. This does not take fault isolation into account. It only considers the probability that the SSR is greater than its detection threshold. The false negative rate (FNR) is defined as the probability that no fault is detected ($S < T$) given that a fault occurs. If only one SSR is considered, these probabilities can be written as

$$\text{FNR}_i = F(T_i, k_{ia}, \lambda_{ia}) \hspace{1cm} (83)$$

$$\text{TPR}_i = 1 - F(T_i, k_{ia}, \lambda_{ia}) \hspace{1cm} (84)$$

where $k_{ia}$ is the total number of sensors in $Y_i$, and $\lambda_{ia}$ is the non-centrality parameter of $S_i$ given that fault $i$ occurred. Note that $k_{ia} \geq k_i$ because $k_i$ is the number of unique sensors in $Y_i$, but $k_{ia}$ is the total number of sensors in $Y_i$. Figure 2 illustrates TPR and FNR for a chi-squared SSR containing $k = 10$ sensors, $\lambda = 40$, and a detection threshold $T = 20$.

Given that some fault occurs, we might isolate the correct fault or we might isolate an incorrect fault. The probability of isolating the correct fault is called the correct classification rate (CCR). In this section we derive lower and upper bounds for the CCR.
Figure 2: Illustration of the noncentral chi-squared pdf of an SSR with \( k = 10 \) sensors and \( \lambda = 40 \). The false negative rate is the area to the left of the user-specified threshold \( T = 20 \), and the true positive rate is the area to the right of the threshold.

3.2.1 Lower bounds for the correct classification rate

Suppose we have only two fault detectors, algorithms 1 and 2, and fault 1 occurs. Consider the probability that SSR\(_1\) is larger than SSR\(_2\) relative to their thresholds. We call this the marginal detection rate \( D_{12} \). Note that we are not considering whether or not the SSRs exceed their threshold. We are only considering how large the SSRs are relative to their thresholds. The marginal detection rate is given as

\[
D_{12} = P[(S_1 - T_1) > (S_2 - T_2)]
\]

\[= P \left[ \left( \sum_i Y_{1i}^2 - T_1 + T_2 \right) > \sum_i Y_{2i}^2 \right] \]

(85)
Assuming that neither $Y_1$ nor $Y_2$ are empty (that is, both sensor sets have some unique sensors), we can use Lemmas 1 and 2 to obtain

$$D_{12} = \int_{\infty}^{-\infty} \left(\int_{\infty}^{y} f(x + T_1 - T_2, k_1, \lambda_1) \, dx\right) f(y, k_2) \, dy \tag{87}$$

$$= \int_{0}^{\infty} (1 - F(y + T_1 - T_2, k_1, \lambda_1)) f(y, k_2) \, dy \tag{88}$$

where

$$\lambda_1 = \sum Y_{1i}^2 \tag{89}$$

If $Y_1$ is empty (sensor set 1 does not have any unique sensors), but $Y_2$ is not empty, the marginal detection rate can be derived as

$$D_{12} = P \left( \sum_i Y_{2i}^2 < T_2 - T_1 \right) \tag{90}$$

$$= F(T_2 - T_1, k_2) \tag{91}$$

If $Y_2$ is empty (sensor set 2 does not have any unique sensors), but $Y_1$ is not empty, the marginal detection rate can be derived as

$$D_{12} = P \left( \sum_i Y_{1i}^2 > T_1 - T_2 \right) \tag{92}$$

$$= 1 - F(T_1 - T_2, k_1, \lambda_1) \tag{93}$$

Now consider the case where there are $n > 2$ fault detection algorithms. Given that fault 1 occurred, the probability that SSR$_1$ is larger than SSR$_i$ for all $i > 1$, relative to their thresholds, is given as

$$D_1 = P \left[ (S_1 - T_1 > S_2 - T_2), \cdots, (S_1 - T_1 > S_n - T_n) \right] \tag{94}$$

$$\geq \prod_{i=2}^{n} D_{1i} \tag{95}$$

where the inequality arises because the events might not be independent. If none of the fault detection algorithms have any sensors in common, then the events are independent and the bound is exact.

Now consider the probability that fault 1 is isolated given that fault 1 occurred. This can be written as

$$CCR_1 = P \left[ (S_1 > T_1), (S_1 - T_1 > S_2 - T_2), \cdots, (S_1 - T_1 > S_n - T_n) \right] \tag{96}$$

$$\geq TPR_1 D_1 \tag{97}$$

where the inequality arises because the events might not be independent. Equation 97 gives a lower bound for the correct classification rate for fault 1.
3.2.2 Upper bounds for the correction classification rate

Next we find an upper bound for the CCR. To begin, suppose that we have only two fault detectors, algorithms 1 and 2. Given that fault 1 occurs, the probability that it is correctly isolated is called the marginal CCR. This can be written as

$$\text{CCR}_{12} = P[(S_1 - T_1 > S_2 - T_2), (S_1 > T_1)]$$ (98)

$$P \left[ \sum_i Y_{1i}^2 > \max \left( \sum_i Y_{2i}^2 + T_1 - T_2, T_1 - \sum_i Y_{ci}^2 \right) \right]$$ (99)

Suppose that both sensor sets have some unique sensors, and the sensor sets also have some common sensors. That is, neither $Y_1$, $Y_2$, nor $Y_c$ are empty. Then we can use Lemmas 1, 2, 3, and 6 to obtain

$$\text{CCR}_{12} = \int_{-\infty}^{\infty} [1 - F(y, k_1, \lambda_1)] [F(y + T_2 - T_1, k_2)f(T_1 - y, k_c, \lambda_c) + f(y + T_2 - T_1, k_2)(1 - F(T_1 - y, k_c, \lambda_c))] \, dy$$ (100)

where $\lambda_c$ is defined analogously to $\lambda_1$ (see Equation 89). In order to limit the integration interval while maintaining accuracy in the computation of $\text{CCR}_{12}$, we use our knowledge that $f(w, k)$ and $f(w, k, \lambda)$ are both zero for $w < 0$, and we numerically find values of $z_2$ and $z_c$ such that $f(z_2, k_2) < \epsilon$ and $f(z_c, k_c, \lambda_c) < \epsilon$ for some small user-specified threshold $\epsilon$. This gives

$$\text{CCR}_{12} = \int_{L}^{U} [1 - F(y, k_1, \lambda_1)] [F(y + T_2 - T_1, k_2)f(T_1 - y, k_c, \lambda_c) + f(y + T_2 - T_1, k_2)(1 - F(T_1 - y, k_c, \lambda_c))] \, dy$$ (101)

$L = \min(T_1 - T_2, T_1 - z_c)$ (102)

$U = \max(T_1, z_2 + T_1 - T_2)$ (103)

If $Y_1$ is empty (sensor set 1 does not have any unique sensors), but $Y_2$ and $Y_c$ are not empty, the marginal CCR can be derived as

$$\text{CCR}_{12} = P \left[ 0 > \max \left( \sum_i Y_{2i}^2 + T_1 - T_2, T_1 - \sum_i Y_{ci}^2 \right) \right]$$ (104)

$$P \left( \sum_i Y_{2i}^2 < T_2 - T_1 \right) P \left( \sum_i Y_{ci}^2 > T_1 \right)$$ (105)

$$F(T_2 - T_1, k_2) [1 - F(T_1, k_c, \lambda_c)]$$ (106)
If \( Y_2 \) is empty (sensor set 2 does not have any unique sensors), but \( Y_1 \) and \( Y_c \) are not empty, the marginal CCR can be derived as

\[
\text{CCR}_{12} = P \left( \sum_i Y_{1i}^2 > T_1 - T_2, \left( \sum_i Y_{1i}^2 > T_1 - \sum_i Y_{ci}^2 \right) \right) \tag{107}
\]

\[
= P \left[ \sum_i Y_{1i}^2 > \max \left( T_1 - \sum_i Y_{ci}^2, T_1 - T_2 \right) \right] \tag{108}
\]

We can use Lemmas 1, 3, and 7 to write this equation as

\[
\text{CCR}_{12} = \int_{T_1 - T_2}^{\infty} [1 - F(y, k_1, \lambda_1)] [f(T_1 - y, k_c, \lambda_c) + (1 - F(T_1 - y, k_c, \lambda_c)) \delta(y - T_1 + T_2)] \, dy \tag{109}
\]

\[
= [1 - F(T_1 - T_2, k_1, \lambda_1)] [1 - F(T_2, k_c, \lambda_c)] + \int_{T_1 - T_2}^{T_1} [1 - F(y, k_1, \lambda_1)] f(T_1 - y, k_c, \lambda_c) \, dy \tag{110}
\]

If \( Y_c \) is empty (the two sensor sets do not have any common sensors), but \( Y_1 \) and \( Y_2 \) are not empty, the marginal CCR can be derived as

\[
\text{CCR}_{12} = P \left[ \sum_i Y_{1i}^2 > \max \left( \sum_i Y_{2i}^2 + T_1 - T_2, T_1 \right) \right] \tag{111}
\]

We can use Lemmas 1, 2, and 7 to write this equation as

\[
\text{CCR}_{12} = \int_{T_1}^{\infty} [1 - F(y, k_1, \lambda_1)] [f(y + T_2 - T_1, k_2) + F(y + T_2 - T_1, k_2) \delta(y - T_1)] \, dy \tag{112}
\]

\[
= [1 - F(T_1, k_1, \lambda_1)] F(T_2, k_2) + \int_{T_1}^{\infty} [1 - F(y, k_1, \lambda_1)] f(y + T_2 - T_1, k_2) \, dy \tag{113}
\]

In order to limit the integration interval while maintaining accuracy in the computation of CCR\(_{12}\), we find \( z \) such that \( f(z, k_2) < \epsilon \) for some small user-specified threshold \( \epsilon \). This gives

\[
\text{CCR}_{12} = [1 - F(T_1, k_1, \lambda_1)] F(T_2, k_2) + \int_{T_1}^{z + T_1 - T_2} [1 - F(y, k_1, \lambda_1)] f(y + T_2 - T_1, k_2) \, dy \tag{114}
\]

The overall CCR for fault 1 is the probability that SSR\(_1\) is greater than its threshold, and greater than all of the other SSRs relative to their thresholds.

\[
\text{CCR}_1 = P \left[ (S_1 > T_1), (S_1 - T_1 > S_2 - T_2), \ldots, (S_1 - T_1 > S_n - T_n) \right] \tag{115}
\]

\[
\leq \min_i \text{CCR}_{1i} \tag{116}
\]
So in order to obtain an upper bound for the CCR of fault 1, we use Equations 102, 106, 110, and 114 as appropriate to find the marginal CCRs. Then we use Equation 116 to find the upper bound for CCR

\[ CCR_1 \].

### 3.3 Fault Misclassification Rates

In this section we derive upper bounds for the probability that a fault is incorrectly isolated. If fault 1 occurs, the probability that fault 2 is isolated is called the misclassification rate \( M_{21} \).

First suppose that we have two fault detection algorithms, algorithms 1 and 2. The misclassification rate can then be written as

\[
M'_{21} = P \left[ \left( S_2 - T_2 > S_1 - T_1, (S_2 > T_2) \right) \right] = P \left[ \sum_i Y^2_{2i} > \max \left( \sum_i Y^2_{1i} + T_2 - T_1, T_2 - \sum_i Y^2_{ci} \right) \right]
\]

where we use the prime symbol on \( M'_{21} \) to denote that only two detection algorithms are in use. Suppose that both sensor sets have some unique sensors, and the sensor sets also have some common sensors. That is, neither \( Y_1 \), \( Y_2 \), nor \( Y_c \) are empty. We can then use Lemmas 1, 2, 3, and 6 to obtain

\[
M'_{21} = \int_{-\infty}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ F(y + T_1 - T_2, k_1, \lambda_1) f(T_2 - y, k_c, \lambda_c) + f(y + T_1 - T_2, k_1, \lambda_1) (1 - F(T_2 - y, k_c, \lambda_c)) \right] dy
\]

In order to limit the integration interval while maintaining accuracy in the computation of \( M'_{21} \), we use our knowledge that \( f(w, k, \lambda) \) is zero for \( w < 0 \), and we find values of \( z_1 \) and \( z_c \) such that \( f(z_1, k_1, \lambda_1) < \epsilon \) and \( f(z_c, k_c, \lambda_c) < \epsilon \) for some small user-specified threshold \( \epsilon \). This gives

\[
M'_{21} = \int_{-\infty}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ F(y + T_1 - T_2, k_1, \lambda_1) f(T_2 - y, k_c, \lambda_c) + f(y + T_1 - T_2, k_1, \lambda_1) (1 - F(T_2 - y, k_c, \lambda_c)) \right] dy
\]

where we use the prime symbol on \( M'_{21} \) to denote that only two detection algorithms are in use. Suppose that both sensor sets have some unique sensors, and the sensor sets also have some common sensors. That is, neither \( Y_1 \), \( Y_2 \), nor \( Y_c \) are empty. We can then use Lemmas 1, 2, 3, and 6 to obtain

\[
M'_{21} = \int_{-\infty}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ F(y + T_1 - T_2, k_1, \lambda_1) f(T_2 - y, k_c, \lambda_c) + f(y + T_1 - T_2, k_1, \lambda_1) (1 - F(T_2 - y, k_c, \lambda_c)) \right] dy
\]

In order to limit the integration interval while maintaining accuracy in the computation of \( M'_{21} \), we use our knowledge that \( f(w, k, \lambda) \) is zero for \( w < 0 \), and we find values of \( z_1 \) and \( z_c \) such that \( f(z_1, k_1, \lambda_1) < \epsilon \) and \( f(z_c, k_c, \lambda_c) < \epsilon \) for some small user-specified threshold \( \epsilon \). This gives

\[
M'_{21} = \int_{-\infty}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ F(y + T_1 - T_2, k_1, \lambda_1) f(T_2 - y, k_c, \lambda_c) + f(y + T_1 - T_2, k_1, \lambda_1) (1 - F(T_2 - y, k_c, \lambda_c)) \right] dy
\]

where we use the prime symbol on \( M'_{21} \) to denote that only two detection algorithms are in use. Suppose that both sensor sets have some unique sensors, and the sensor sets also have some common sensors. That is, neither \( Y_1 \), \( Y_2 \), nor \( Y_c \) are empty. We can then use Lemmas 1, 2, 3, and 6 to obtain

\[
M'_{21} = \int_{-\infty}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ F(y + T_1 - T_2, k_1, \lambda_1) f(T_2 - y, k_c, \lambda_c) + f(y + T_1 - T_2, k_1, \lambda_1) (1 - F(T_2 - y, k_c, \lambda_c)) \right] dy
\]

In order to limit the integration interval while maintaining accuracy in the computation of \( M'_{21} \), we use our knowledge that \( f(w, k, \lambda) \) is zero for \( w < 0 \), and we find values of \( z_1 \) and \( z_c \) such that \( f(z_1, k_1, \lambda_1) < \epsilon \) and \( f(z_c, k_c, \lambda_c) < \epsilon \) for some small user-specified threshold \( \epsilon \). This gives

\[
M'_{21} = \int_{-\infty}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ F(y + T_1 - T_2, k_1, \lambda_1) f(T_2 - y, k_c, \lambda_c) + f(y + T_1 - T_2, k_1, \lambda_1) (1 - F(T_2 - y, k_c, \lambda_c)) \right] dy
\]
We can use Lemmas 1, 3, and 7 to write this as

\[ M'_{21} = \int_{T_2-T_1}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ f(T_2 - y, k_c, \lambda_c) + (1 - F(T_2 - y, k_c, \lambda_c)) \delta(y - T_2 + T_1) \right] dy \]

\[ = \left[ 1 - F(T_2 - T_1, k_2) \right] \left[ 1 - F(T_1, k_c, \lambda_c) \right] + \int_{T_2-T_1}^T \left[ 1 - F(y, k_2) \right] f(T_2 - y, k_c, \lambda_c) dy \] (125)

If \( Y_2 \) is empty (sensor set 2 does not have any unique sensors), but \( Y_1 \) and \( Y_c \) are not empty, the misclassification rate can be derived as

\[ M'_{21} = P \left[ 0 > \max \left( \sum_i Y_{2i}^2 + T_2 - T_1, T_2 - \sum_i Y_{ci}^2 \right) \right] \] (126)

\[ = P \left( \sum_i Y_{2i}^2 < T_1 - T_2 \right) P \left( \sum_i Y_{ci}^2 > T_2 \right) \] (127)

\[ = F(T_1 - T_2, k_1, \lambda_1) \left[ 1 - F(T_2, k_c, \lambda_c) \right] \] (128)

If \( Y_c \) is empty (the two sensor sets do not have any common sensors), but \( Y_1 \) and \( Y_2 \) are not empty, the misclassification rate can be derived as

\[ M'_{21} = P \left[ \sum_i Y_{2i}^2 > \max \left( \sum_i Y_{1i}^2 + T_2 - T_1, T_2 \right) \right] \] (129)

We can use Lemmas 1, 2, and 7 to write this equation as

\[ M'_{21} = \int_{T_2}^{\infty} \left[ 1 - F(y, k_2) \right] \left[ f(y + T_1 - T_2, k_1, \lambda_1) + \right] \left[ 1 - F(y, k_2) \right] f(y + T_1 - T_2, k_1, \lambda_1) dy \] (130)

\[ = \left[ 1 - F(T_2, k_2) \right] F(T_1, k_1, \lambda_1) + \int_{T_2}^{z+T_2-T_1} \left[ 1 - F(y, k_2) \right] f(y + T_1 - T_2, k_1, \lambda_1) dy \] (131)

In order to limit the integration interval while maintaining accuracy in the computation of \( M'_{21} \), we find \( z \) such that \( f(z, k_1, \lambda_1) < \epsilon \) for some small user-specified threshold \( \epsilon \). This gives

\[ M'_{21} = \left[ 1 - F(T_2, k_2) \right] F(T_1, k_1, \lambda_1) + \int_{T_2}^{z+T_2-T_1} \left[ 1 - F(y, k_2) \right] f(y + T_1 - T_2, k_1, \lambda_1) dy \] (132)

Given that we have \( n > 2 \) detection algorithms running in parallel, the misclassification rate \( M_{21} \) is bounded from above by \( M'_{21} \). So in order to obtain an upper bound for \( M_{21} \), we use Equation 121, 125, 128, or 132 as appropriate. This can be repeated for all marginal
misclassification rates $M_{ij}$. This gives
\[
M_{ij} = P[(S_2 - T_2 > S_1 - T_1), (S_2 - T_2 > S_3 - T_3), \cdots, (S_2 - T_2 > S_n - T_n), (S_2 > T_2)]
\]
\[
\leq M'_{ij}, \quad (i = 1, \cdots, n), (j = 1, \cdots, n), (i \neq j)
\]  \hspace{1cm} (134)

Finally we consider the probability $M_{0i}$ that no fault is indicated when fault $i$ occurs. This misclassification rate can be bounded from above as
\[
M_{0i} = P(S_1 < T_1, \cdots, S_n < T_n)
\]  \hspace{1cm} (135)
\[
\leq P(S_i < T_i)
\]  \hspace{1cm} (136)
\[
M_{0i} \leq F(T_i, k_{ia}, \lambda_{ia})
\]  \hspace{1cm} (137)

### 3.4 Summary of Confusion Matrix Bounds

Recall the confusion matrix shown in Table 1. The rows correspond to fault conditions, and the columns correspond to fault isolation results. The element in the $i$th row and $j$th column is the probability that fault $j$ is isolated when fault $i$ occurs. The previous sections derived the following bounds.

- **CCR$_i$** for $i \in [1, n]$ is the probability that fault $i$ is correctly isolated given that it occurs, and its lower and upper bounds are given in Equations 97 and 116.
- **CNR** is the probability that a no-fault condition is correctly indicated given that no fault occurs, and its lower and upper bounds are given in Equation 62.
- **$M_{ij}$** for $i, j \in [1, n]$ and $i \neq j$ is the probability that fault $i$ is incorrectly isolated given that fault $j$ occurs, and its upper bound is given in Equation 134.
- **$M_{0i}$** for $i \in [1, n]$ is the probability that fault $i$ is incorrectly isolated given that no fault occurs, and its upper bound is given in Equation 82.
- **$M_{0i}$** for $i \in [1, n]$ is the probability that no fault is isolated given that fault $i$ occurs, and its upper bound is given in Equation 137.

### 3.5 Computational Effort

Usually confusion matrices are obtained with simulations. In order to derive an experimental confusion matrix with $N$ faults, the number of matrix elements that needs to be calculated is on the order of $N^2$. (For example, if the number of faults doubles, then the computational effort quadruples.) Also, the required number of simulations for each matrix element calculation is on the order of $N$. This is because as the number of possible faults increases, the number of simulations required to obtain the same statistical accuracy increases in direct proportion. Therefore the computational effort required for the experimental determination of a confusion matrix is on the order of $N^3$. 

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The bounds derived in this paper also require computational effort that is on the order of $N^3$. This is because each of the bounds summarized in Section 3.4 required computational effort on the order of $N$, and the number of matrix elements is on the order of $N^2$.

4 Simulation Results

In this section we use simulation results to verify the theoretical bounds of the preceding sections. We consider the problem of isolating an aircraft turbofan engine fault which is modeled by the NASA Commercial Modular Aero-Propulsion System Simulation (C-MAPSS) [25]. There are five possible faults that can occur: fan, low pressure compressor (LPC), high pressure compressor (HPC), high pressure turbine (HPT), and low pressure turbine (LPT). These five faults entail shifts of both efficiency and flow capacity from nominal values. The fault magnitudes that we try to detect are 2.5% for the fan, 20% for the LPC, 2% for the HPC, 1.5% for the HPT, and 2% for the LPT. These magnitudes were chosen to give reasonable fault detection ability. The LPC fault has a very small fault signature, so it is not detectable unless its magnitude is relatively large.

The available sensors and their standard deviations are shown in Table 2. The fault influence coefficient matrix shown in Table 3 was generated using C-MAPSS and is based on [26]. The numbers in Table 3 are the partial derivatives of the sensor outputs with respect to the fault conditions, normalized to the fault percentages discussed above, and normalized to one standard deviation of the sensor noise.

Table 2: Aircraft engine sensors and standard deviations. The temperature sensor standard deviations are given in units of degrees Rankine. All other sensor standard deviations are given as a percentage relative to their nominal values.

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Description</th>
<th>Standard deviation</th>
</tr>
</thead>
<tbody>
<tr>
<td>Nc</td>
<td>Core speed</td>
<td>0.25%</td>
</tr>
<tr>
<td>P15</td>
<td>Bypass duct pressure</td>
<td>0.5%</td>
</tr>
<tr>
<td>P24</td>
<td>LPC outlet pressure</td>
<td>0.5%</td>
</tr>
<tr>
<td>Ps30</td>
<td>HPC outlet pressure</td>
<td>0.5%</td>
</tr>
<tr>
<td>T24</td>
<td>LPC outlet temperature</td>
<td>1 deg</td>
</tr>
<tr>
<td>T30</td>
<td>HPC outlet temperature</td>
<td>2 deg</td>
</tr>
<tr>
<td>T48</td>
<td>HPT outlet temperature</td>
<td>8 deg</td>
</tr>
<tr>
<td>Wf</td>
<td>Fuel flow</td>
<td>0.75%</td>
</tr>
</tbody>
</table>

In order to decide which sensors to use for detecting each fault, we included one sensor at a time in a fault detection algorithm, starting with the sensor with the largest fault signature. This gave a total of eight possible sensor sets for each fault detection algorithm. We specified a maximum allowable false positive rate of 0.0001, and calculated the smallest threshold for each possible sensor set that would give an FPR no greater than 0.0001 (see Equation 26 and Figure 1). Given the threshold, we next calculated the true positive rate (see Equation 84 and Figure 2). We then chose the sensor set that gave the largest TPR.
Table 3: Fault signatures. The rows show the five different fault conditions. The columns show the mean sensor value residuals for the given fault conditions, normalized to one standard deviation.

<table>
<thead>
<tr>
<th>Sensors</th>
<th>Nc</th>
<th>P15</th>
<th>P24</th>
<th>Ps30</th>
<th>T24</th>
<th>T30</th>
<th>T48</th>
<th>Wf</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Fan</strong></td>
<td>0.80</td>
<td>2.10</td>
<td>1.80</td>
<td>4.05</td>
<td>0.43</td>
<td>0.49</td>
<td>1.21</td>
<td>3.40</td>
</tr>
<tr>
<td><strong>LPC</strong></td>
<td>0.00</td>
<td>0.00</td>
<td>4.80</td>
<td>1.20</td>
<td>3.20</td>
<td>0.20</td>
<td>0.80</td>
<td>0.27</td>
</tr>
<tr>
<td><strong>HPC</strong></td>
<td>0.72</td>
<td>0.08</td>
<td>0.32</td>
<td>0.64</td>
<td>0.54</td>
<td>5.23</td>
<td>3.08</td>
<td>1.60</td>
</tr>
<tr>
<td><strong>HPT</strong></td>
<td>0.96</td>
<td>0.12</td>
<td>0.39</td>
<td>3.27</td>
<td>0.72</td>
<td>2.63</td>
<td>4.40</td>
<td>2.18</td>
</tr>
<tr>
<td><strong>LPT</strong></td>
<td>1.20</td>
<td>0.12</td>
<td>0.60</td>
<td>3.56</td>
<td>0.90</td>
<td>3.34</td>
<td>0.03</td>
<td>2.32</td>
</tr>
</tbody>
</table>

As an example, consider the fan fault with the normalized fault signatures shown in Table 3. The sensors with the largest fault signatures in descending order are Ps30, Wf, T30, P15, P24, T48, Nc, and T24. This gives eight potential sensor sets for detecting a fan fault: the first potential set uses only sensor Ps30, the second potential set uses Ps30 and Wf, and so on. The potential sensor sets along with their detection thresholds and TPRs are shown in Table 4. Table 4 shows that using five sensors gives the largest TPR given the constraint that FPR ≤ 0.0001.

Table 4: Potential sensor sets for detecting a fan fault. The thresholds were determined by constraining FPR ≤ 0.0001. This table shows that using five sensors gives the largest TPR subject to the FPR constraint.

<table>
<thead>
<tr>
<th>Sensors</th>
<th>Detection threshold $T_1$</th>
<th>True positive rate TPR$_1$</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ps30</td>
<td>15.1</td>
<td>0.563</td>
</tr>
<tr>
<td>Ps30, Wf</td>
<td>18.4</td>
<td>0.865</td>
</tr>
<tr>
<td>Ps30, Wf, T30</td>
<td>21.1</td>
<td>0.926</td>
</tr>
<tr>
<td>Ps30, Wf, T30, P15</td>
<td>23.5</td>
<td>0.949</td>
</tr>
<tr>
<td><strong>Ps30, Wf, T30, P15, P24</strong></td>
<td><strong>25.7</strong></td>
<td><strong>0.959</strong></td>
</tr>
<tr>
<td>Ps30, Wf, T30, P15, P24, T48</td>
<td>27.9</td>
<td>0.958</td>
</tr>
<tr>
<td>Ps30, Wf, T30, P15, P24, T48, Nc</td>
<td>29.9</td>
<td>0.952</td>
</tr>
<tr>
<td>Ps30, Wf, T30, P15, P24, T48, Nc, T24</td>
<td>31.8</td>
<td>0.942</td>
</tr>
</tbody>
</table>

This process described in the previous paragraph was repeated for each fault shown in Table 3. The resulting sensor sets are shown in Table 5 and were therefore chosen for FDI for each fault type. Note that given an FPR constraint, the detection threshold is a function only of the number of sensors in each sensor set; the detection threshold is independent of the specific fault signatures. This is illustrated in Figure 1 where it is seen that $f(x, k)$ is a function only of $x$ and $k$ (the number of sensors).

Finally we used the fault isolation method shown in Equation 64, and we used the equations developed in the previous sections to determine theoretical lower and upper bounds for the confusion matrix as summarized in Section 3.4. We then ran 100,000 fault simulations in order to obtain an experimental confusion matrix. Table 6 shows the theoretical lower
bounds of the diagonal elements of the confusion matrix. Lower bounds of the off-diagonal elements were not obtained because we are typically more interested in upper bounds of off-diagonal elements. Table 7 shows the theoretical upper bounds of the confusion matrix. Table 8 shows the experimental confusion matrix. These tables show that the theoretical results derived in this paper give reasonably tight bounds to the experimental confusion matrix values.

Recall that we used an FPR of 0.0001 to choose our sensor sets and detection thresholds. This means that the first five elements in the last row of Table 7 are guaranteed to be no greater than 0.0001. It further means that the element in the lower right corner of Table 6 is guaranteed to be no greater than $1 - 5(0.0001) = 0.9995$.

Table 5: Sensor sets for fault detection. These sensor sets give the largest TPR for each fault given the constraint that FPR $\leq 0.0001$.

<table>
<thead>
<tr>
<th>Fault $i$</th>
<th>Sensor set $i$</th>
<th>Detection threshold $T_i$</th>
<th>True positive rate TPR$_i$</th>
</tr>
</thead>
<tbody>
<tr>
<td>Fan</td>
<td>Ps30, Wf, T30, P15, P24</td>
<td>25.7</td>
<td>0.959</td>
</tr>
<tr>
<td>LPC</td>
<td>P24, T24</td>
<td>18.4</td>
<td>0.943</td>
</tr>
<tr>
<td>HPC</td>
<td>T30, T48</td>
<td>18.4</td>
<td>0.970</td>
</tr>
<tr>
<td>HPT</td>
<td>T48, Ps30, T30, Wf</td>
<td>23.5</td>
<td>0.970</td>
</tr>
<tr>
<td>LPT</td>
<td>Ps30, T30, Wf</td>
<td>21.1</td>
<td>0.844</td>
</tr>
</tbody>
</table>

Table 6: Lower bounds of diagonal confusion matrix elements. Lower bounds for the off-diagonal elements have not been obtained. The rows specify the actual fault condition, and the columns specify the diagnosis.

<table>
<thead>
<tr>
<th></th>
<th>Fan</th>
<th>LPC</th>
<th>HPC</th>
<th>HPT</th>
<th>LPT</th>
<th>No Fault</th>
</tr>
</thead>
<tbody>
<tr>
<td>Fan</td>
<td>0.6691</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>LPC</td>
<td></td>
<td>0.9342</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>HPC</td>
<td></td>
<td></td>
<td>0.8692</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>HPT</td>
<td></td>
<td></td>
<td></td>
<td>0.9345</td>
<td></td>
<td></td>
</tr>
<tr>
<td>LPT</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>0.6623</td>
<td></td>
</tr>
<tr>
<td>No Fault</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>0.9992</td>
</tr>
</tbody>
</table>

Table 7: Upper bounds of confusion matrix elements. The rows specify the actual fault condition, and the columns specify the diagnosis.

<table>
<thead>
<tr>
<th></th>
<th>Fan</th>
<th>LPC</th>
<th>HPC</th>
<th>HPT</th>
<th>LPT</th>
<th>No Fault</th>
</tr>
</thead>
<tbody>
<tr>
<td>Fan</td>
<td>0.7761</td>
<td>0.0000</td>
<td>0.0001</td>
<td>0.1115</td>
<td>0.1899</td>
<td>0.0408</td>
</tr>
<tr>
<td>LPC</td>
<td>0.0076</td>
<td>0.9356</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0573</td>
</tr>
<tr>
<td>HPC</td>
<td>0.0097</td>
<td>0.0000</td>
<td>0.8936</td>
<td>0.0769</td>
<td>0.0160</td>
<td>0.0303</td>
</tr>
<tr>
<td>HPT</td>
<td>0.0015</td>
<td>0.0000</td>
<td>0.0270</td>
<td>0.9445</td>
<td>0.0014</td>
<td>0.0300</td>
</tr>
<tr>
<td>LPT</td>
<td>0.0874</td>
<td>0.0000</td>
<td>0.0030</td>
<td>0.1066</td>
<td>0.7422</td>
<td>0.1557</td>
</tr>
<tr>
<td>No Fault</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0001</td>
<td>0.9999</td>
</tr>
</tbody>
</table>
Table 8: Experimental confusion matrix. The rows specify the actual fault condition, and the columns specify the diagnosis. The numbers are based on 100,000 simulations of each fault. The numbers in each row should add up to 1 (within rounding error).

<table>
<thead>
<tr>
<th></th>
<th>Fan</th>
<th>LPC</th>
<th>HPC</th>
<th>HPT</th>
<th>LPT</th>
<th>No Fault</th>
</tr>
</thead>
<tbody>
<tr>
<td>Fan</td>
<td>0.7614</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0370</td>
<td>0.1677</td>
<td>0.0338</td>
</tr>
<tr>
<td>LPC</td>
<td>0.0073</td>
<td>0.9354</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0573</td>
</tr>
<tr>
<td>HPC</td>
<td>0.0051</td>
<td>0.0000</td>
<td>0.8875</td>
<td>0.0713</td>
<td>0.0074</td>
<td>0.0288</td>
</tr>
<tr>
<td>HPT</td>
<td>0.0016</td>
<td>0.0000</td>
<td>0.0276</td>
<td>0.9422</td>
<td>0.0011</td>
<td>0.0275</td>
</tr>
<tr>
<td>LPT</td>
<td>0.0831</td>
<td>0.0000</td>
<td>0.0015</td>
<td>0.0993</td>
<td>0.6680</td>
<td>0.1481</td>
</tr>
<tr>
<td>No Fault</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0000</td>
<td>0.0001</td>
<td>0.9997</td>
</tr>
</tbody>
</table>

Note that it is possible for an element in the experimental confusion matrix in Table 8 to lie outside the bounds shown in Tables 6 and 7. For example, compare the numbers in the fourth row and first column in Tables 7 and 8. This is because the numbers in Table 8 are experimentally obtained on the basis of a finite number of simulations, and are guaranteed to lie within their theoretical bounds only as the number of simulations approaches infinity. In fact, that is one of the strengths of the analytic method proposed in this paper. The analytic bounds are definite, but simulations are subject to random effects. Also, simulations can give misleading conclusions if the simulation has errors. One common simulation error is the non-randomness of commonly used random number generators [27].

In summary, the user specifies the maximum FPR for each fault, and then finds the sensor set that has the largest TPR given the FPR constraint. Analytic confusion matrix bounds are then obtained using the theory in this paper. If the results are not satisfactory, the user can iterate by changing the maximum FPR constraint. For example, if a TPR is too small, then the user will have to increase the FPR constraint. If the confusion matrix bounds of fault isolation probabilities are not satisfactory, the user will have to iterate on the FPR constraints in order to obtain different confusion matrix bounds.

5 Conclusion

This paper has introduced a new fault detection and isolation (FDI) algorithm and derived analytical confusion matrix bounds. The FDI algorithm is fairly simple and has not been compared with other algorithms. The main contribution of this paper is the generation of analytic confusion matrix bounds, and the possibility that our methodology could be adapted to other FDI algorithms. Usually confusion matrices are obtained with simulations. Such simulations have several potential drawbacks. First, they can be time consuming. Second, they can give misleading conclusions if not enough simulations are run to give statistically significant results. Third, they can give misleading conclusions if the simulation has errors (for example, if the output of the random number generator does not satisfy statistical tests for randomness). The theoretical confusion matrix bounds derived in this paper do not depend on a random number generator and can be used in place of simulations.
Further work in this area could follow several directions. First, the tightness of the confusion matrix bounds could be quantified. This paper derives bounds but does not guarantee how loose or tight those bounds are. Second, the bounds could be modified to be tighter. Third, bounds could be attempted for methods other than the FDI algorithm proposed here. The fault isolation method we used isolates the fault that has the largest sum of squares of sensor residuals (SSR) relative to its detection threshold. Other fault isolation methods could normalize the relative SSR to its standard deviation, or could normalize the absolute SSR to its detection threshold. Preliminary efforts have not been successful in deriving bounds for these fault isolation methods, but additional effort might bring success. All of these FDI methods are static, which means that faults are isolated using measurements at a single time. Better fault isolation might be achieved if dynamic system information is used. The derivation of theoretical confusion matrix bounds in this case would require additional work.

References


<table>
<thead>
<tr>
<th>REPORT DATE (DD-MM-YYYY)</th>
<th>01-07-2009</th>
<th>2. REPORT TYPE</th>
<th>Technical Memorandum</th>
</tr>
</thead>
<tbody>
<tr>
<td>4. TITLE AND SUBTITLE</td>
<td>Analytic Confusion Matrix Bounds for Fault Detection and Isolation Using a Sum-of-Squared-Residuals Approach</td>
<td></td>
<td></td>
</tr>
<tr>
<td>6. AUTHOR(S)</td>
<td>Simon, Dan; Simon, Donald, L.</td>
<td></td>
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</tr>
<tr>
<td>7. PERFORMING ORGANIZATION NAME(S) AND ADDRESS(ES)</td>
<td>National Aeronautics and Space Administration John H. Glenn Research Center at Lewis Field Cleveland, Ohio 44135-3191</td>
<td></td>
<td></td>
</tr>
<tr>
<td>8. PERFORMING ORGANIZATION REPORT NUMBER</td>
<td>E-16998</td>
<td></td>
<td></td>
</tr>
<tr>
<td>9. SPONSORING/MONITORING AGENCY NAME(S) AND ADDRESS(ES)</td>
<td>National Aeronautics and Space Administration Washington, DC 20546-0001</td>
<td></td>
<td></td>
</tr>
<tr>
<td>10. SPONSORING/MONITOR’S ACRONYM(S)</td>
<td>NASA</td>
<td></td>
<td></td>
</tr>
<tr>
<td>11. SPONSORING/MONITORING REPORT NUMBER</td>
<td>NASA/TM-2009-215655</td>
<td></td>
<td></td>
</tr>
<tr>
<td>12. DISTRIBUTION/AVAILABILITY STATEMENT</td>
<td>Unclassified-Unlimited Available electronically at <a href="http://gltrs.grc.nasa.gov">http://gltrs.grc.nasa.gov</a> This publication is available from the NASA Center for AeroSpace Information, 443-757-5802</td>
<td></td>
<td></td>
</tr>
<tr>
<td>13. SUPPLEMENTARY NOTES</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>14. ABSTRACT</td>
<td>Given a system which can fail in 1 or ( n ) different ways, a fault detection and isolation (FDI) algorithm uses sensor data in order to determine which fault is the most likely to have occurred. The effectiveness of an FDI algorithm can be quantified by a confusion matrix, which indicates the probability that each fault is isolated given that each fault has occurred. Confusion matrices are often generated with simulation data, particularly for complex systems. In this paper we perform FDI using sums of squares of sensor residuals (SSRs). We assume that the sensor residuals are Gaussian, which gives the SSRs a chi-squared distribution. We then generate analytic lower and upper bounds on the confusion matrix elements. This allows for the generation of optimal sensor sets without numerical simulations. The confusion matrix bounds are verified with simulated aircraft engine data.</td>
<td></td>
<td></td>
</tr>
<tr>
<td>15. SUBJECT TERMS</td>
<td>Gas turbine engines; Systems health monitoring; Fault detection; Statistical analysis</td>
<td></td>
<td></td>
</tr>
<tr>
<td>16. SECURITY CLASSIFICATION OF:</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>a. REPORT</td>
<td>U</td>
<td></td>
<td></td>
</tr>
<tr>
<td>b. ABSTRACT</td>
<td>U</td>
<td></td>
<td></td>
</tr>
<tr>
<td>c. THIS PAGE</td>
<td>U</td>
<td></td>
<td></td>
</tr>
<tr>
<td>17. LIMITATION OF ABSTRACT</td>
<td>UU</td>
<td></td>
<td></td>
</tr>
<tr>
<td>18. NUMBER OF PAGES</td>
<td>32</td>
<td></td>
<td></td>
</tr>
<tr>
<td>19a. NAME OF RESPONSIBLE PERSON</td>
<td>STI Help Desk (email: <a href="mailto:help@sti.nasa.gov">help@sti.nasa.gov</a>)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>19b. TELEPHONE NUMBER (include area code)</td>
<td>443-757-5802</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>